

Form PTO-1449 U.S. DEPARTMENT OF COMMERCE (REV. 7-80) PATENT AND TRADEMARK OFFICE  <b>LIST OF PRIOR ART CITED BY APPLICANT</b>  <i>(Use several sheets if necessary)</i>				<b>Atty. Docket No. (Optional)</b>  15608		<b>Application Number</b>  Unassigned  10/626,800		
				<b>Applicant(s)</b> Raul Curbelo				
				<b>Filing Date</b> Herewith		<b>Group Art Unit</b> Unassigned 2878		
<b>U.S. PATENT DOCUMENTS</b>								
EXAMINER INITIAL*		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If appropriate)	
OG	AA	4,682,022	7/21/87	Hoult et al.				
OG	AB	4,927,269	5/22/90	Keens et al.				
OG	AC	5,262,635	11/16/93	Curbelo				
	AD							
	AE							
<b>FOREIGN PATENT DOCUMENTS</b>								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
<b>OTHER DOCUMENTS</b> <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>								
OG		Schindler R.A., "Correcting for Nonlinearity in a Photodetector", <i>NASA Tech Briefs</i> 10(2), Item 52 (1986)						
OG		Zhang Z.M. et al., "Absolute Detector Calibration Applied to Nonlinearity Error Correction in FT-IR Measurements", <i>Applied Spectroscopy</i> 51(4):576-579 (1997)						
OG		Rahmelow K., "Electronic Influences on an Infrared Detector Signal: Nonlinearity and Amplification", <i>Applied Optics</i> 36(10):2123-2132 (1997)						
OG		Palchetti L. et al., "Assessment of Detector Nonlinearity in Fourier Transform Spectroscopy", <i>Applied Spectroscopy</i> 56(2):271-274 (2002)						
EXAMINER				DATE CONSIDERED				
OGC GCL				06/18/04				
* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								